Nanostructured Single Crystals Sandwiched between Ordered/Disordered Coily and Rod Brushes

Agbolaghi, Samira*
Chemical Engineering Department, Faculty of Engineering, Azarbaijan Shahid Madani University, Tabriz, I.R. IRAN

Abbaspoor, Saleheh
Institut of Polymeric Materials, Sahand University of Technology, Tabriz, I.R. IRAN

Alizadeh-Osguei, Mona
School of Aerospace, Mechanical and Manufacturing Engineering, RMIT University, Melbourne, AUSTRALIA

Nazari, Maryam
Department of Chemistry, University of Calgary, Calgary, CANADA

Abbasi, Farhang
Institute of Polymeric Materials, Sahand University of Technology, Tabriz, I.R. IRAN

ABSTRACT: Single crystals of poly(ethylene glycol) (PEG)-b-polystyrene (PS), PEG-b-polymethyl methacrylate) (PMMA), PEG-b-polycaprolactone (PCL), and polyaniline (PANI)-b-PEG-b-PANI were developed from dilute solutions and thin molten films using self-seeding methodology. The PS and PMMA grafted chains were categorized in disordered nano-brushes; however, the PCL and PANI ones were grouped in ordered nano-brushes. The characteristics of grown single crystals such as surface morphology, growth planes, and thicknesses were investigated using Atomic Force Microscopy (AFM), Electron Diffraction (ED) in Transmission Electron Microscopy (TEM), and Small Angle X-ray Scattering (SAXS). The thickness of PEG substrates, as well as polymer nano-brushes, were in the nanoscale (2-150 nm). Furthermore, the special morphologies of polymer mixed-brushes developed through the growth of single crystals of PEG-b-PS and PEG-b-PMMA diblock copolymers were introduced and characterized. Regardless of different morphologies, the total, substrate and amorphous thicknesses, tethering density as well as ED patterns were compatible in the phase regions covered by similar nano-brushes.

KEYWORDS: Disordered/ordered; Nano-brush; Self-seeding; Single crystal; Morphology.

INTRODUCTION

Polymer single crystals (PSCs) have shown numerous applications, e.g., PSC growth directed programmable
assembly of nanoparticles [1], nano-hybrid shish-kebabs to mimic the natural bone nanostructures [2], magnetically recyclable catalyst support [3-7], templates to synthesize nanoparticle clusters [8,9], substrates for anisotropic deposition of Au nanoparticles [10], utilizable in semiconductor microelectronics and solid-state [11,12], simplified ultrathin film system to probe the interfacial properties of different substrates [13], the amino-functionalized lamellar poly(L-lactide) single crystals as a delivery system for human papillomaviruses (HPV16-E7) -associated tumors [14-16], nano/micromotors [17,18], etc. In the conductive materials field, large single rectangular crystals of the regioregular octamer of 3-hexyl-thiophene (3HT) [19,20], well-defined single crystalline nanowires of rigid rod conjugated poly(p-phenylene ethynylene) derivatives with thioacetate end groups (TA-PPE) [21], single nano-whiskers of poly(3-hexylthiophene) (P3HT) [22], one dimensional (1D) microwire single crystals of P3HT (regioregularity = 98.5%) [12,23], self-organized P3HT with its supramolecular two dimensional (2D) structure [24,25], poly(3-octylthiophene) (P3OT) single crystals through solvent vapor annealing process [26], etc were reported.

Polymer brushes having high sensitivity to environmental alterations could be employed in many applications such as biomaterials, microfluidic devices, tissue engineering, membrane surface modification, colloidal stabilization, chemical sensors, and ion-exchange adsorbents [27-31]. A surface-grafted monolayer having a combination of various properties is obtainable via fabrication of the polymer mixed-brushes. It is noteworthy that due to the presence of different polymer brushes with various behaviors in mixed-brush structures, they are capable of introducing a wide range of morphologies and responses [32,33]. To construct mixed-brushes, various methods such as grafting to [34-36], grafting from [37-41], a combination of these approaches, single crystal growth of block copolymers [42], and patterning of single crystal surface [43-50] have been previously presented.

In the current work, the highly crystalline PEG structures covered by the hairy or nano-brush regions with rod and coily configurations have been investigated from the perspective of dimensions, surface patterning, ordering, and brush conformation by SAXS, AFM, and SAED TEM analyses.

EXPERIMENTAL SECTION

The PEG-b-PS, PEG-b-PMMA, PANI-b-PEG-b-PANI, and PEG-b-PCL block copolymer systems were synthesized via Atom Transfer Radical Polymerization (ATRP), interfacial polymerization, and ring opening polymerization [43,47]. To fabricate the single crystals of crystalline-amorphous block copolymers, the self-seeding method was utilized [51,52]. In brief, a solution crystallization was carried out with a dilute concentration of 0.009 wt % of solute in amyl acetate. The sample was put into a cell tube containing solvent, and heated above the dissolution temperature of the sample in the solvent in a temperature-controllable oil bath and kept for about 10-15 minutes; subsequently, the cell tube containing sample and solvent was transferred to another bath at present crystallization temperature which was appropriately below the room temperature, lasting 5-6 hours for fast crystallization, and then immersed into a given self-seeding temperature oil bath (T, = 41 °C for all samples), and kept for 20 min. The cell tube in question was then quickly switched into an isothermal oil bath with desired crystallization temperature (23-32 °C) and maintained for 2-3 days.

The chemical structure of block copolymers was confirmed by 1HNMR spectroscopy on a Bruker (Avance DPX) spectrometer working at 400 MHz. The characteristics of single crystals were investigated by AFM, Nanoscope III in the tapping mode, transmission electron microscope (TEM, EM 208 Philips) equipped with Selected Area Electron Diffraction (SAED) facility, and Bruker-AXS Nanostar SAXS with a counts rate of 1000 s/sec/channel and spatial resolution of 400-500 µm.

RESULTS AND DISCUSSIONS

In the current work, we developed distinct types of single crystalline grained structures at different temperatures and preparation conditions using PEG-b-PS, PEG-b-PMMA, PANI-b-PEG-b-PANI, and PEG-b-PCL block copolymers. The PANI nanorods were rigid and rod, the PS nano-brushes were extended coily, the PMMA nano-brushes were packed coily, and PCL nano-brushes were ordered on the PEG crystalline substrates. By mixing the coily brushes of PS and PMMA, various surface morphologies were also detected for the developed grained nanostructures.
**Disordered coily brush-covered nanostructured single crystals**

The particular morphologies detected in growth systems of mixed-brush single crystals were categorized into some species: disperses in snake-, ring-, and dumbbell-shape formed from PMMA brushes in PS-matrix, patched surface areas covered by PS and PMMA grafted chains and random channel-like morphologies with alternative channels constructed from two different phases. Amyl acetate was a very good solvent for PS blocks and a partially poor solvent for PMMA blocks [53]. The PS tethered chains had repulsive interaction with the corresponding substrate surface [4], thereby, detection of the different phase regions covered with extended PS and partially packed pancake PMMA tethered chains was feasible on the substrate. Figs. 1(a) and (b) depict AFM height and phase images of matrix (PS)-dispersed (PMMA) surface morphology of PEG5000-b-PS4600/PEG5000-b-PMMA17100 grown at Tc = 30 °C, respectively. The height variance and average domain sizes were 2.70 and 303 nm, respectively. These parameters were 1.89 and 302 nm at Tc = 23 °C. This type of arrangement for the coily PS and PMMA brushes was attributed to their conformations originated from the solvent quality and interaction with the single crystalline substrate. Fig. 1(c) illustrates ring-like surface morphology of PEG5000-b-PS4600/PEG5000-b-PMMA17100 grown at Tc = 32 °C having a height variance of 4.90 nm. It is noteworthy that the corresponding sample possessing leopard skin-like morphology demonstrated a height variance of 4.88 nm. Hence, regardless of fabricated morphologies, the height variances were highly compatible with each other. Fig. 1(d) shows the patched surface morphology for PEG5000-b-PS4600/PEG5000-b-PMMA13100 single crystal grown at Tc = 30 °C, in which the height variance between the PS- and PMMA-covered phases was 3.62 nm. Figs. 1(e) and (f) present narrow channel-wire surface morphology of PEG5000-b-PS10000/PEG5000-b-PMMA17100 single crystal grown at Tc = 30 °C (height variance = 4.80 nm) and broad channel-wire surface morphology of PEG5000-b-PS10000/PEG5000-b-PMMA13100 single crystal grown at Tc = 23 °C (height variance = 5.22 nm), respectively. In a constant molecular weight of PS brushes, i.e., 10000 g/mol, via enhancing the molecular weight of PMMA tethered chains from 13100 to 17100 g/mol, the width of channels decreased. Distinct crystallization temperatures (23 and 30 °C) did not affect the domain size and shape.

The constructed mixed-brush surface morphologies were not in the request of any selective solvent to be detected. Regarding the density variance and different hardness of the PMMA and PS amorphous blocks [54], detection of phase regions on the single crystal substrate was possible. In addition to the mentioned parameters, thanks to different qualities of applied solvent in growth conditions for PS brushes, we were able to investigate the height variances. Furthermore, the type of interaction of different tethered chains with substrate surface (repulsive and attractive for PS and PMMA tethered chains, respectively) could, in turn, be considered as the most effective parameter on detection of phase regions.

The tethering density (the number of tethered chains in a unit area of the surface [55]) and crystalline substrate thickness were determined based on Equations (1) and (2), respectively [3,4].

\[
\rho = \frac{1}{S} = \frac{1}{2M_n^{\text{CRYST}}} = \frac{N_A \rho_{\text{CRYST}} d_{\text{CRYST}}}{2M_n^{\text{CRYST}}}
\]

\[
d_{\text{CRYST}} = \frac{d_{\text{total}}}{\frac{M_n^{\text{CRYST}}}{\rho_{\text{CRYST}}} + \frac{M_n^{\text{AM}}}{\rho_{\text{AM}}}}
\]

Where \( \sigma, N_A, \rho_{\text{CRYST}}, d_{\text{CRYST}}, M_n^{\text{CRYST}}, d_{\text{total}}, M_n^{\text{AM}}, \rho_{\text{AM}} \) stood for the tethering density, Avogadro number (\( \approx 6.022 \times 10^{23} \) mol\(^{-1} \)), crystalline PEG density (1.239 g/cm\(^3\) at room temperature) [56], PEG substrate thickness (Equation (2)), molecular weight of PEG (5000 g/cm\(^3\) for all samples), total thickness, molecular weight of amorphous blocks, density of amorphous blocks (1.19 g/cm\(^3\)) [53] for PMMA and 1.05 g/cm\(^3\)) [56] for PS, respectively.

Through conducting AFM analyses with more scrutiny on various samples, and comparing achieved height profiles, it was clear that irrespective of shape and size of areas covered by PMMA brushes in PS-matrix, the total, substrate, and amorphous brushes thickness were similar in different morphologies for a given molecular weight of tethered chains. In Figs. 2(a) and (b), AFM height images of snake-like and matrix-dispersed surface morphologies are demonstrated for mixed-brush single crystals of PEG5000-b-PS10000/PEG5000-b-PMMA17100
Fig. 1: AFM Nanoscope images of mixed-brush single crystals. The height image of matrix (PS)-dispersed (PMMA) surface morphology of PEG5000-b-PS4600/PEG5000-b-PMMA17100 grown at Tc = 30 °C (the maximum z-scale is 5 nm), height variance: 2.70 nm, domain size: 303 nm (a) continued by respective phase image (b); ring-like surface morphology of PEG5000-b-PS4600/PEG5000-b-PMMA17100 grown at Tc = 32 °C (the maximum z-scale is 5 nm), height variance: 4.90 nm (c); four-patched surface morphology of PEG5000-b-PS4600/PEG5000-b-PMMA13100 grown at Tc = 30 °C (the maximum z-scale is 5 nm), height variance: 3.62 nm (d); narrow channel-wire surface morphology of PEG5000-b-PS10000/PEG5000-b-PMMA17100 grown at Tc = 30 °C (the maximum z-scale is 5 nm), height variance: 4.80 nm (e); broad channel-wire surface morphology of PEG5000-b-PS10000/PEG5000-b-PMMA13100 grown at Tc = 23 °C (the maximum z-scale is 5 nm), height variance: 5.22 nm (f).

The weight ratio of PEG-b-PS/PEG-b-PMMA diblock copolymers was 50/50 for cocrystallization of all samples.

grown at Tc = 23 °C. When the molecular weights of PS and PMMA blocks were constant in 14800 and 17100 g/mol and the growth conditions were fixed, irrespective of shape and size of disperses in both morphologies, the total thicknesses in PS and PMMA covered regions were about 18.40 and 12.30 nm, respectively (the error percentage was below 3%). Consequently, the thicknesses of the crystalline and amorphous parts were 4.06 and 2.72 nm as well as 7.17 and 4.79 nm, respectively. These figures are valid for all other single crystals with special and random morphologies. In more details, for given molecular weights of PS and PMMA brushes, either PMMA’s were dispersed in PS-matrix with any shape and size or they were spread with nearly 50/50 proportion in PS-PMMA channel-wire morphologies, the thicknesses were somehow equal in respective phase regions (again, the error percentage was below 3-4%). Moreover, for samples in which the molecular weights of one type of brush were similar but those of the other ones were not the thicknesses for the regions covered with brushes having the same molecular weight were equal with each other (the error percentage was below 5%). Quantitatively, the total, substrate, and amorphous thicknesses as well as tethering density for mixed-brush single crystals of PEG5000-b-PS10000/PEG5000-b-PMMA13100 and PEG5000-b-PS10000/PEG5000-b-PMMA13100 grown at Tc = 30 °C, were 18.23 and 16.12 nm, 5.47 and 7.74 nm, 3.39 and 3.37 nm, 0.253 and 0.251 cm² for PS phase regions, and similarly were 12.51 and 12.48 nm, 6.38 and 4.18 nm, 0.408 and 0.577 cm² for PMMA phase regions. In these two samples, due to the fixed molecular weight of PMMA
tethered chains (≈ 13100 g/mol), the characteristics of regions covered with them proved each other, regardless of molecular weight of brushes in the neighboring phase as well as shape and size of disperses. For single crystals possessing special and random surface morphologies, in which PS brushes were matrix and PMMA tethered chains were disperses, a meaningful variance was observed in the size and length of disperses in parallel with the alterations of amorphous blocks molecular weight. For example, in morphologies having alternate channel-wire patterns, via increasing the PS and PMMA blocks molecular weight, the width of channels decreased. Furthermore, for morphologies, in which the PMMA covered areas having snake shape were spread in the PS-matrix, via enhancing the molecular weight of amorphous chains, the average length of snakes decreased. In these systems, the PMMA average domain size had a decreasing trend with molecular weight enhancement [43]. Besides, in the epitaxial structures fabricated by our research group, for channels patterned with matrix-dispersed morphologies, a similar trend was also detected for the PMMA disperses. Another elegant trend discovered in our empirical trials was the reduction of the average domain size of PEG-disperses in PS- and PMMA-matrix in cocrystallization of homo (PEG) and PEG-b-PS as well as PEG-b-PMMA diblock copolymer chains. The reason for the formation of a limited population of special morphologies (nearly 3%) besides the 97% of patterned and regular leopard skin-like morphologies could be associated with high PDI in growth systems. Due to the range of variety of amorphous blocks length, they may have more opportunities to be included in different morphologies of growing single crystals. The morphologies, in which

Fig. 2: AFM Nanoscope images of mixed-brush single crystals. Snake-like surface morphology of PEG_{15000}-b-PS_{14000}/PEG_{5000}-b-PMMA_{17100} (grown at $T_c = 23$ °C), left: height image (the maximum z-scale is 5 nm), height variance: 6.10 nm, right: height profile (a); leopard skin-like surface morphology of PEG_{15000}-b-PS_{14000}/PEG_{5000}-b-PMMA_{17100} (grown at $T_c = 23$ °C), left: height image (the maximum z-scale is 5 nm), height variance: 6.15 nm, domain size: 286 nm, right: height profile (b). The weight ratio of PEG-b-PS/PEG-b-PMMA diblock copolymers was 50/50 for cocrystallization of all samples.
the portion of PMMA chains on the single crystal was less than that in ideal and patterned mixed-brush morphologies, actually possessed the longer amorphous blocks. Therefore, this phenomenon diminished the number of chains having higher hindrance. The longer PMMA chains played a more significant role; because they had packed pancake conformation due to their presence in partially poor solvent and their attractive interaction with PEG substrate. That is why, upon entering into the single crystal structure, the osmotic pressure against the similar tethers increased; because the amorphous tethered chains to prepare their demanded surface area to occupy caused the PEG crystallizable chains to have more foldings. On the other hand, via enhancement of the PS chains length, the osmotic pressure and steric repulsion for the presence of other chains also increased. Here, the hindrance against the PS stretched chains was less than that of the PMMA grafts, thereby the system preferred to further absorb the PS chains and, consequently, they developed the matrix phase. Irrespective of some scarce surface morphologies, in which the portion of PS and PMMA chains was equal on the single crystal surface (random channel-wire morphologies having alternative channels), in most of morphologies (possessing either ideal and predictable inside-filled circle disperses or ring-, dumbbell-, and snake-like patches) the portion of PS brushes on the surface of single crystal was higher than that of PMMA ones. It could be ascribed to packed pancake conformation of PMMA brushes and, consequently, their higher steric repulsion. We predict that at 23-32 °C, even in good and poor solvents for the PMMA and PS blocks, respectively, due to a dominant effect of the attractive interaction between the PMMA brushes and PEG substrate surface, they would have more packed conformation in comparison to PS ones [57]. Hence, more percentage of diblock copolymers having the PS block will be able to be included in the single crystal structure and, subsequently, be part of the matrix phase. Even in an inverse growth condition, the domination of the PS chains population will be beyond question, and they are capable of being a matrix in over 99% of the fabricated surface morphologies. Furthermore, for preparing convenient analyses condition to detect the various phase regions in mixed-brushes, the molecular weight of PMMA chains was high in comparison to that of PS ones. In addition to conformation, the longer chains of PMMA blocks could, in turn, elevate the osmotic pressure.

In the channel-like single crystals, the central channel covered by the PS and PMMA mixed-brushes was in the role of seed (core), and the outer layer was composed of PMMA homo brush single crystal. It could be related to different interactions of tethered chains with the substrate surface. Besides all experimental parameters such as solvent quality and molecular weight, the interaction dictates the conformation [57]. We speculate that in some morphologies with infinitesimal or snake-like disperses, the PMMA brushes were longer; because the growth center tended to decrease the hindrance of similar chains. In simple words, in inside-filled PMMA-disperses, the hindrance of PMMA chains against each other was higher than that of extended or hollow ones; because, in the latter ones, the border line between PMMA and PS tethered chains were longer and it could, in turn, reduce the hindrance.

By comparing the SAED patterns obtained for predictable leopard skin-like and special morphologies, it was concluded that they were to some extent similar. Either the PMMA brushes regularly and controllably were patterned in the PS-matrix or irregularly and unpredictably were dispersed in the same matrix, the growth fronts and their priority were the same; because the diblock copolymers possessed the same crystalline blocks. In conclusion, the surface morphology and the type of amorphous brushes and their molecular weight had no impact on the structure of crystalline substrate and (120) growth fronts. Figs. 3(a) and (b) illustrate the scanning transmission electron microscopy (STEM) image of PEG5000-b-PS5000/PEG5000-b-PMMA300 single crystals grown in amyl acetate at T_c = 28 °C and the scheme of various surface patterning in PEG-b-PS/PEG-b-PMMA single crystals. For PEG3000-b-PS5000/PEG5000-b-PMMA300 mixed-brush single crystals whose SAED patterns are illustrated in Fig. 3(c) and (d), the dominant fronts for both patterned matrix-dispersed and special morphologies were (120) prisms. Besides (120) dominant growth fronts, (110) and (020) weak spots were also detected. In these types of brush-covered nanostructures, the PS and PMMA grafted chains were categorized as disordered brushes; because, in the SAED patterns, only the spots of crystalline PEG substrate were detected. Similar results were reported in our previous works [58,59].

**Ordered coily and rod brush-covered nanostructured single crystals**

When PEG5000-b-PCL4700/PEG5000-b-PS18500 single crystals were grown as another type of mixed-brush
single crystals from molten thin films, a co-continuous surface morphology was acquired. In these types of mixed-brush single crystalline grains, the grafted brushes also demonstrated an ordered structure in the SAED patterns. Figs. 4(a-c) depict STEM image of PEG$\text{5000-b-}$PCL$\text{4700}/$PEG$\text{5000-b-}$PS$\text{18500}$ single crystals grown from melt state at $T_c = 28$ °C and the corresponding surface morphology and SAED pattern. In SAED pattern, (120) growth planes were for the crystalline PEG substrate, and (110) and (200) spots stood for the PCL ordered epitaxially grown structures on the PEG substrate. In these types of nanostructures, the characteristics of developed grains were directly measured using SAXS analyses. Because Equations (1) and (2) did not satisfy the condition of crystalline PCL brushes. The height variance between the crystalline PCL ($d^{\text{overall}}_{\text{PCL}} = 22.61$ nm, $d^{\text{PEG}}_{\text{PCL}} = 10.93$ nm, $d^{\text{PCL}}_{\text{PCL}} = 5.84$ nm) and amorphous PS ($d^{\text{overall}}_{\text{PS}} = 46.56$ nm, $d^{\text{PEG}}_{\text{PS}} = 8.69$ nm, $d^{\text{PS}}_{\text{PS}} = 18.93$) brushes was 23.95 nm. Therefore, the distinction between various kinds of nano-brush phases was easily possible.

Different parts of Fig. 5 depict STEM image of PANI$\text{16520-b-}$PEG$\text{5000-b-}$PANI$\text{16520}$ single crystals grown from the melt state at $T_c = 18$ °C, the corresponding dispersed-dispersed surface morphology, and AFM phase image. Based on AFM height profile and AFM ImageJ software, the PANI nanofiber diameter ranged from 6 to 8 nm. In AFM phase image of PANI nanorod-covered single crystals, the whole surface of single crystal was in a united phase. In the Interface Distribution Function (IDF) of SAXS, the first peak stood for the thickness of the crystalline substrate ($d^{\text{PEG}}_{\text{PANI}} = 4.85$ nm) and the second peak indicated the twice of the thickness of PANI brushes (2$d^{\text{PANI}}_{\text{PANI}} = 298.02$ nm). Although the PANI nanorods...
were not crystallizable, their arrangement on the PEG single crystals was categorized as the ordered brushes; because they were fully extended and orderly arranged in the vicinity of each other. Here, the thickness of the PEG substrate did not vary by an increase of PANI molecular weight. This was due to the extended conformation of PANI brushes on the PEG3500 substrates. By lengthening the PANI nanofibers, their exerted osmotic pressure onto the substrate surface did not change, and from the beginning, only PANI nanofibers having too small diameters have been allowed to be entered into the single crystals.

CONCLUSIONS

Various ordered and disordered polymer nano-brushes with distinct surface morphologies were developed through the growth of single crystals from dilute solution and thin molten films comprising PEG-b-PS and PEG-b-PMMA, PEG-b-PCL, and PANI-b-PEG-b-PANI block copolymers. The features of PS/PMMA covered mixed-brush single crystals including the surface of various PS- and PMMA-covered phases, the total, substrate, and amorphous thicknesses resembled that of patterned morphologies. The PS and PMMA nano-brushes were categorized in disordered brushes; however, the PCL and PANI ones were grouped in ordered brushes. The characteristics of grown single crystals such as surface morphology, growth planes, and thicknesses were investigated using AFM, SAED, and SAXS analyses.
REFERENCES


